

電鍍鎳組織與機械性質之研究

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摘要

本研究藉由建立電鍍鎳“製程-鍍層微結構-機械性質”的關係，瞭解鎳鍍層經高溫受熱後的微結構與機械性質。實驗中使用胺基磺酸鎳浴，電鍍操作條件分別為鍍液溫度（40~50）、電流密度（0.5A/dm²~4.0A/dm²）、pH值（3.0~5.0），並改變鍍液成分如氨離子、氯離子，於銅板上製備70 μm的鎳鍍層，再將鍍層做200~600的熱處理以探討鎳層受熱軟化的趨勢，然後以橫截面光學顯微鏡（OM）、橫截面掃描式電子顯微鏡（SEM）、橫截面和平面向穿透式電子顯微鏡（TEM）及X-射線繞射分析，觀察鍍層組織與結晶缺陷分析和鍍層的優選方位。實驗結果顯示在40 鍍液中，電流密度小於1.0A/dm²時，鎳鍍層呈纖維晶構造，結晶優選取向為〔110〕，鍍層硬度較高，鍍層經400 以上熱處理後，產生再結晶與晶粒的成長，當電流密度大於1.0A/dm²時，鎳鍍層呈明顯柱狀晶結構，為強烈〔100〕優選方位，同時其硬度較低，鍍層經600 熱處理仍然保持柱狀結構。在0.5A/dm²~4.0A/dm²下製備的鎳層皆呈大晶粒與小晶粒混合的雙集合結構，晶粒大小隨著電流密度增加而增加，但其結晶缺陷密度卻隨電流密度增加而減少，高電流密度製備的鎳層晶粒較粗大且其結晶缺陷較少，導致鍍層硬度較低。於40 鍍液中，pH值3.0~5.0製備的鍍層，皆為明顯柱狀晶結構，結晶優選取向為強烈的〔100〕，鍍層硬度隨著pH值的升高而升高，鍍層經600 熱處理後，仍然為柱狀晶結構。於40 鍍液中，無添加氨離子時，鎳鍍層呈柱狀結構，為〔100〕優選方位，結晶缺陷密度低，鍍層硬度低，氨離子含量300ppm時，鍍層為較弱〔100〕優選方位，結晶缺陷密度高，導致硬度提高，當氨離子含量300ppm以上，鎳鍍層呈纖維晶結構，結晶優選取向為〔110〕，鍍層經400 以上熱處理後，有再結晶的現象與晶粒的成長。鍍液溫度50，無添加氨離子時，鎳層呈纖維結構，結晶優選取向為〔110〕，當氨離子含量100ppm以上，鎳層呈纖維結構，結晶優選取向為〔110〕和〔310〕，鎳層結晶缺陷密度高，導致硬度提昇，鎳層經400 以上熱處理後，產生粗大且不規則的再結晶晶粒與晶粒成長。添加3g/l~30g/l的含水氯化鎳之40 鍍液中製備的鎳層呈柱狀晶結構，為〔100〕優選方位，鎳層經600 熱處後，仍然為柱狀晶結構，當添加量30g/l以上，鎳鍍層為纖維結構，呈較弱〔100〕優選方位，鎳層經400 以上熱處理後，有再結晶的現象與晶粒的成長。從添加3g/l~60g/l含水氯化鎳的50 鍍液中製備的鎳鍍層呈纖維結構，優選取向為〔110〕，經400 熱處理後，產生再結晶與晶粒的成長。

關鍵詞：胺基磺酸鎳浴；穿透式電子顯微鏡；纖維晶；再結晶與晶粒成長；柱狀晶；優選方位

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